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The Non-Destructive and Nano-Microstructural Characterization of Thermal-Barrier Coatings

Y.H. Sohn, B. Jayaraj, S. Laxman, B. Franke, J.W. Byeon, and A.M. Karlsson

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The durability of thermal barrier coatings (TBCs) plays an important role in the service reliability and maintainability of hot-section components in advanced turbine engines for aerospace and utility applications. Photostimulated luminescence spectroscopy (PSLS) and electrochemical impedance spectroscopy (EIS) are being concurrently developed as complimentary non-destructive evaluation (NDE) techniques for quality control and life-remain assessment of TBCs. This paper discusses recent achievements in understanding the residual stress, phase constituents, and electrochemical resistance (or capacitance) of TBC constituents—with an emphasis on the thermally grown oxide. Results from NDE by PSLS and EIS are correlated to the nano- and microstructural development of TBCs.

INTRODUCTION

Thermal-barrier coatings (TBCs) consisting of 7–8 wt.% Y_2O_3 stabilized ZrO_2 (YSZ), applied by air-plasma spray (APS) (Figure 1a), or electron-beam physical vapor deposition (EB-PVD) (Figure 1b), play a critical role in the performance and reliability of modern gas turbine engines.^{1–4} The insulating YSZ coatings are deposited on internally-cooled hot-section components and provide a thermal gradient between the hot exhaust gas and the metallic surface. Oxygen diffuses through the ceramic coating and oxidizes the alumina-forming MCrAlY (M = Ni and/or Co) or (Ni,Pt)Al bond coats, which is an intermediate coating layer between the YSZ and the superalloy. As a result of oxidation, the thermally

grown oxide (TGO), consisting primarily of $\alpha-Al_2O_3$, forms and grows with associated growth stress.

In addition to mechanical load associated with the use-pattern of a gas turbine, TBCs are subjected to thermo-mechanical load during thermal cycling due to the thermal expansion mismatch between the metallic substrate and the ceramic coatings. The effect of the thermal mismatch alone can give rise to stresses as high as 4 GPa in the TGO at room temperature.^{5–7} Thus, failures frequently occur during cooling or once ambient temperature is reached. The damage evolution up to the final failure

is often related to a complex evolution of the microstructure, where damage during thermo-mechanical cycling initiates at multiple interfacial flaws in the vicinity of the TGO. With continued cycling the flaws eventually link up and the TBCs fail by the spallation of the TGO and/or YSZ coating. After TBC spallation, the bond coat is directly exposed to high-temperature gas, leading to accelerated degradation of the bond coat and superalloy components.^{1–4,8,9}

Since TBC failure frequently involves component failure and unscheduled maintenance of gas turbine engines, it is important that the integrity of TBCs be nondestructively evaluated by examining the characteristics of TBCs including residual stress, thickness and the phase constituents of the TGO, as well as the presence of any insipient damage. Non-destructive evaluation (NDE) of these characteristics can provide critical information regarding the damage/failure modes of TBCs and can be a part of parameters monitored for lifetime management of TBCs and engine operation.

The development of TBCs with enhanced durability and reliability along with a mechanism-based life prediction model require refined understanding of failure mechanisms based on detailed analysis at the nano- and microscopic scale, coupled with mechanics-based failure evaluation. The focus in this paper will be on novel tools for nano- and microstructural analysis. Some investigations on microstructural development using transmission-electron microscopy (TEM) and scanning TEM (STEM) have been reported,^{10–14} but specimen preparation of thermally cycled TBCs has been difficult due to the extremely fragile nature of specimens with multiple interfaces.

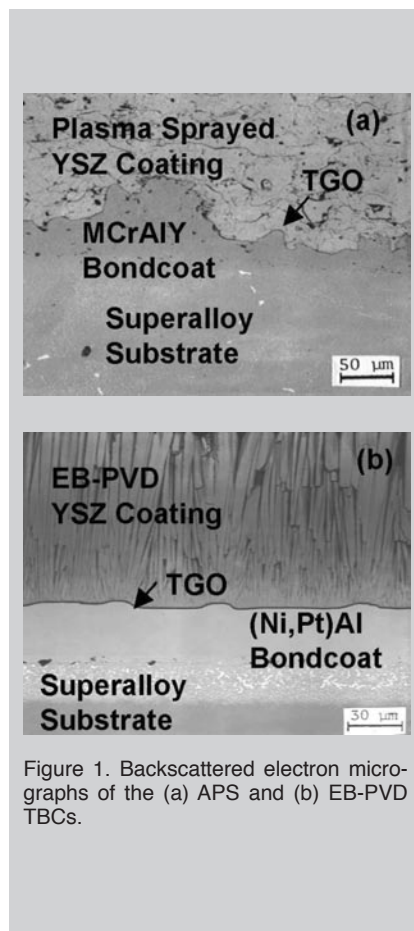


Figure 1. Backscattered electron micrographs of the (a) APS and (b) EB-PVD TBCs.

PSLS AND EIS: COMPLIMENTARY NDE TECHNIQUES

Critical factors typically associated with the spallation failure include the thickness of the TGO, the residual stress of the TGO, and the phase constituents, especially the polymorphic transformation of the Al_2O_3 in the TGO scale.^{1-4,15} These three characteristics of TBCs can be examined non-destructively by using both photostimulated spectroscopy (PSLS) and electrochemical impedance spectroscopy (EIS). However, failure mechanisms are unique for each TBC system. There is, for example, no unique value for maximum TGO thickness.¹⁶ Nor is there one critical TGO stress that can be used for all systems.⁵⁻⁷ Instead, TGO stress has to be selected for the particular system used and must be based on structural evaluation linked to mechanisms-based modeling.

The use of PSLS as an NDE technique for TBCs was pioneered by Clarke and refined by several researchers.^{5,6,17-26} The governing principles and the applicability of PSLS has been extensively reported,^{5,6,17-26} particularly for the determination of residual stress of the $\alpha\text{-Al}_2\text{O}_3$ in the TGO scale, and polymorphic phase constituents of Al_2O_3 (e.g., γ , θ , and α phases).

Figure 2 represents a typical evolution

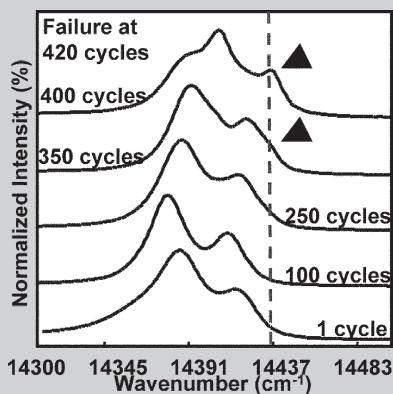


Figure 2. The typical photostimulated luminescence spectra as a function of 1 h thermal cycling for EB-PVD TBCs with (Ni,Pt)Al bond coats. The TBC spallation occurred after 420 cycles while the luminescence from stress-relieved TGO scale (marked by arrows) was observed starting 350 cycles.

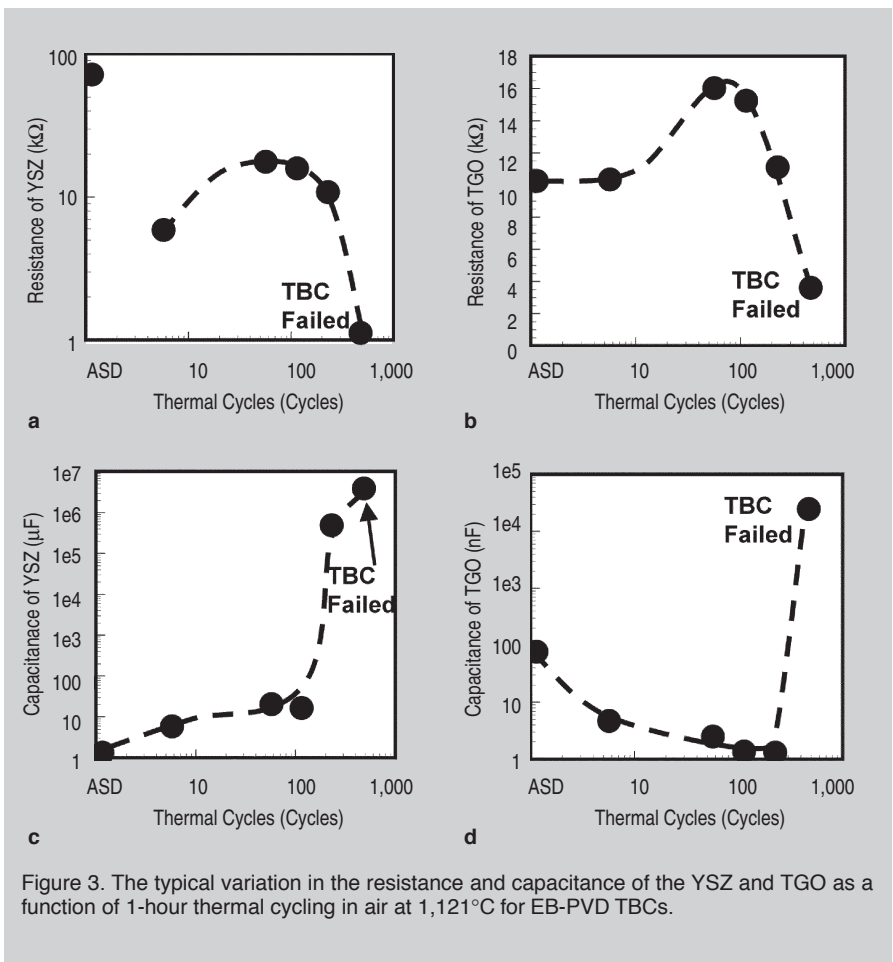


Figure 3. The typical variation in the resistance and capacitance of the YSZ and TGO as a function of 1-hour thermal cycling in air at 1,121°C for EB-PVD TBCs.

of photoluminescence spectra as a function of 1 h thermal cycling at 1,121°C (10 min. heat-up, 40 min. dwell, and 10 min. forced-air-quench) for an EB-PVD TBC with (Ni,Pt)Al bond coat and CMSX-4 superalloy substrate. While the failure of the TBC specimen occurred after 420 cycles, a detectable increase in luminescence associated with the stress relief of the TGO scale emerged starting at 350 cycles²⁷ underneath the YSZ topcoat. After 400 cycles, more than half of 20 randomly selected non-destructive measurements detected the localized stress relief associated with sub-critical damage in the TGO scale.²⁷ A corresponding microstructural analysis reveals that there is significant damage in the TGO scales prior to the final failure. The damage modes observed included ratcheting and/or cracking from out-of-plane tensile stress in the vicinity of asperities in (Ni,Pt)Al grain boundary ridges.^{2,3,28}

Electrochemical impedance spectroscopy is an NDE technique that measures electrochemical impedance of materials

with an applied voltage with varying frequency. The electrochemical impedance characteristics of TBCs may depend on the thickness and microstructure of the YSZ coating, the thickness and microstructure of the TGO, and potentially, the damage at critical interfaces in the vicinity of the TGO.²⁹⁻³¹ Figure 3 represents a typical evolution in the electrochemical resistance (R) and capacitance (C) of the YSZ topcoat and the TGO scale. In this study, EB-PVD TBCs with NiCoCrAlY bond coats and IN738 superalloy substrates were tested using the 1 h thermal cycle at 1,121°C. The failure of the TBC specimen occurred after 419 cycles.²⁹ There was an initial increase in the R_{YSZ} and an initial decrease in the C_{YSZ} with thermal cycling. The R_{TGO} and C_{TGO} also exhibited an initial increase and decrease, respectively. Experimental results based on a sintering study of monolithic YSZ with open pores and isothermal/cyclic oxidation study of Al_2O_3 -forming alloys have demonstrated that the initial variation in the R_{YSZ} , C_{YSZ} , R_{TGO} , and C_{TGO} with high-temperature exposure

can be attributed to the sintering of the YSZ and the growth of the TGO scale.^{31,32} In fact, the thickness of the TGO scale and the C_{TGO} were inversely related, as the theory predicts. With further thermal cycling, gradual decreases in R_{YSZ} and R_{TGO} were observed as well as abrupt increases in the C_{YSZ} and C_{TGO} . These changes correlated to the damage within the TBC, through which the conductive electrolyte can penetrate and short-circuit with a conductive metallic substrate. This correlation between damage and electrochemical impedance was also demonstrated using a sinter-and-quench study of monolithic YSZ with open pores, and isothermal/cyclic oxidation study of Al_2O_3 -forming alloys.^{31,32} In addition, EIS has demonstrated its potential to examine the processing-dependent changes in the microstructure of TBCs, including thickness, chemistry, and porosity.³⁰

NANO-MICROSCALE CHARACTERIZATION BY TEM/STEM VIA FIB-INLO

Most microstructural analysis of TBCs has relied on qualitative correlation based on resolution-limited x-ray diffraction, and SEM with EDS. However, recent developments in nano- and microstructural evaluation techniques have opened up new ventures. For example, a TEM/STEM analysis carried out using focused ion beam–in-situ lift-out (FIB-INLO) for the specimen preparation is particularly useful for fragile specimens such as TBCs.^{33–35}

In preparing the site-specific TEM specimen of TBCs using FIB-INLO, the cross-sectional samples are embedded in transparent cold-setting epoxy, and ground using 600-grit SiC paper, followed by polishing with diamond paste down to 1/4 μm . The polished surface of the specimens is then sputter coated with Au-Pd to create adequate conduction during FIB imaging and milling operations. First, a wedge-shaped, site-specific specimen is cut free from the bulk material by means of FIB milling. The sample is then attached to the in-situ tungsten probe using ion-beam assisted platinum chemical vapor deposition (CVD). Next, the ion-beam assisted platinum CVD is used to attach the sample to a 2 mm \times 1 mm copper TEM grid that had been previously cut to accommodate access to the grid with

the in-situ tungsten probe. Once it is secured to the TEM grid, the sample is milled free from the in-situ tungsten probe and then milled to electron transparency. The sequential images of the specimen preparation via FIB-INLO are presented in Figure 4.

Once the TEM specimen is prepared using FIB-INLO, the nanostructure and microstructure of the TBCs can be analyzed using TEM and STEM techniques. In this study, a Philips/FEI Tecnai F30 300KeV TEM, equipped with high-angle annular dark-field (HAADF) and x-ray energy-dispersive spectroscopy (XEDS) was employed to examine the microstructure of the as-coated and

thermally cycled TBCs.^{33–35} In these studies, HAADF (i.e., analogous to backscatter-electron imaging), electron diffraction, and fast-Fourier transformed (FFT) diffractograms were employed to identify phase constituents, particularly the polymorphic make-up of the Al_2O_3 in the TGO scale, and were correlated to the non-destructive phase identification via PSLs.³³

Figure 5 shows the bright-field image of thermally cycled EB-PVD TBC with grit-blasted (Ni,Pt)Al bond coat, a thick TGO (nearly 8 μm) scale, and the development of extensive decohesion at the YSZ/TGO interface after 645 10-h thermal cycles at 1,038°C.²⁷ No apparent

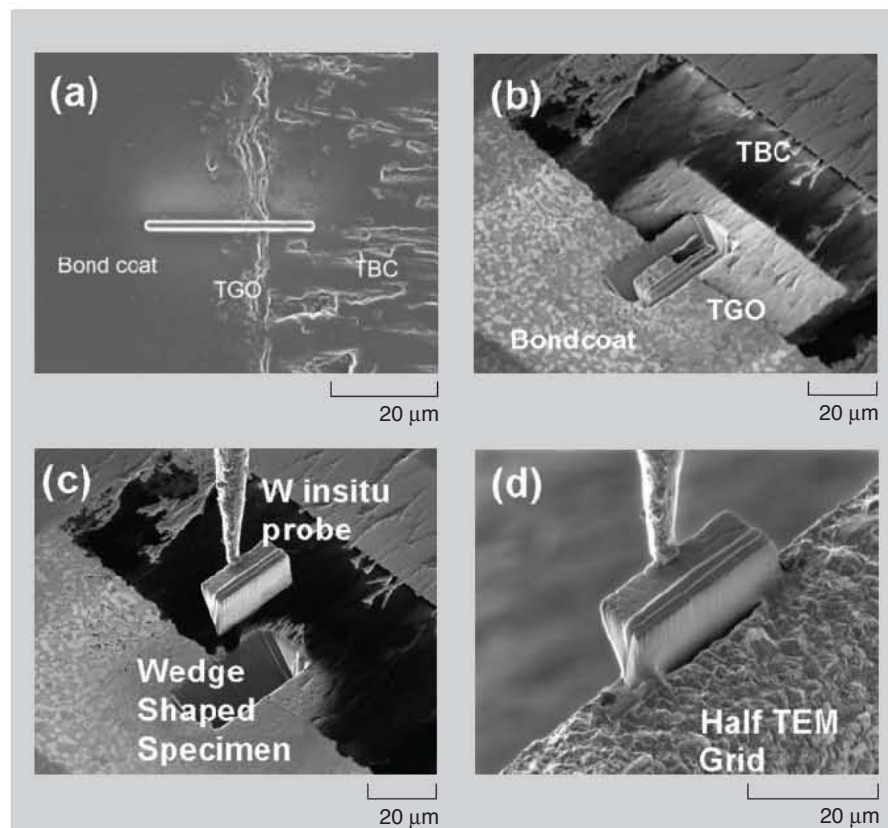


Figure 4. Secondary electron FIB images showing the sequence of the FIB INLO TEM specimen preparation process for a representative TBC specimen.³³

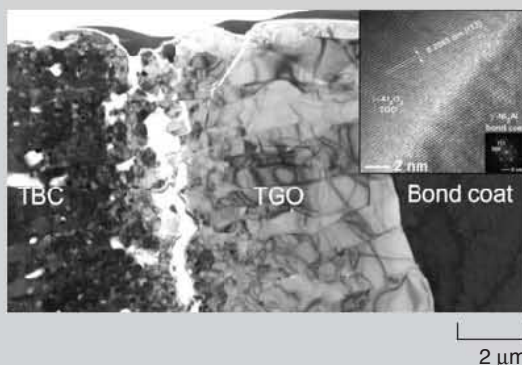


Figure 5. A bright-field TEM micrograph of an intact EB-PVD TBC specimen after 645 10-h thermal cycles at 1,038°C. Extensive decohesion at or near the YSZ/TGO ($\alpha-Al_2O_3$) interface was observed. The FFT diffractogram (inset) from the bond coat corresponds to that of $\gamma-Ni_3Al$ solid-solution phase.³⁴

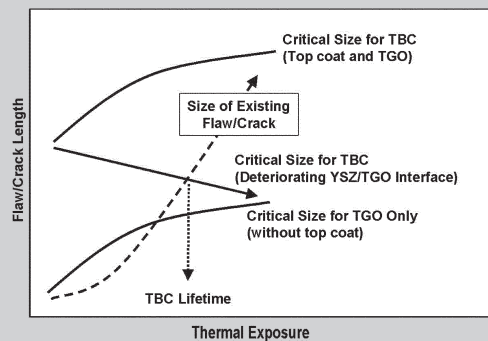


Figure 6. The evolution of critical flaw size required for the buckling failure of TBCs with and without the deterioration of the YSZ/TGO interface.

damage was observed at the TGO-to-bond-coat interface as illustrated by the high-resolution image presented in the inset of Figure 5. The formation of voids/decohesion at the YSZ/TGO interface has been observed frequently via TEM/STEM examination as a function of thermal exposure.³³ For the material system under consideration, the constrained volumetric changes associated with the polymorphic transformation of Al_2O_3 and morphological change of TGO scale (i.e., rumpling and/or ratcheting) may cause this damage at the YSZ/TGO interface.

Observation of decohesion at the YSZ/TGO interface in Figure 5 warrants a further discussion since this set of samples displayed an interesting failure evolution not documented previously. Delamination buckling is a fairly complex failure mechanism, where a crack reaching a critical size allows the coating to release its strain energy by buckling. Once the coating has buckled, the configuration becomes unstable, resulting in continued crack and buckle propagation,^{36,37} often leading to spallation. A thicker coating is more resistant to buckling, but it can store more energy for potentially driving a crack once the instability is reached.

The presence of a YSZ topcoat suppresses the buckling of the TGO scale, provided that the YSZ/TGO interface remains adhered, as illustrated in Figure 6. In other words, the critical flaw size required for TBC (YSZ + TGO) is larger than that for TGO only. With deterioration of the YSZ/TGO interface, as observed by TEM/STEM, the buckling failure of TBC requires a smaller

flaw (or a crack) size (e.g., critical enough just for the TGO) with the addition of more thermal cycling (i.e., increasing strain energy release rate) as illustrated in Figure 6. Thus, if the amount of voids increases to a critical level, the YSZ is not suppressing the TGO and the TGO is free to buckle. The results can be dramatic large-scale buckling and spallation.

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